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108		5,872,625		2/1999		KAJINO et al.							
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Py M	Ni	shijima et al., '	'Moiré	Patterns:	Their Applica	ation to Refractive	Index and			adient			
42	Ве	Measurements", <u>Journal of the Optical Society of America</u> , Vol. 54, pp. 1-5, January 1964 Benton et al., "Simplified Talbot Interferometers for Lens Testing", <u>Optical Engineering</u> , Vol. 15, pp. 328-331, July-August 1976.											
طرر		Bolognini et al., "Interferometry based on the Lau effect a quasi-ray description", Optica Acta, Vol. 32, pp. 409-422, 1985.											
al	pa	Pirga-et-al., "Two-directional spatial-carrier phase-shifting method for analysis of crossed and closed fringe patterns", Optical Engineering, pp. 2459-2466, Vol. 34, August 1995.											
S	65	Morimoto et al., "Application of moire analysis of strain using Fourier transform", Optical Engineering, pp. 650-656, Vol. 27, August 1988.											
کر	Or	Keren et al., "An Optical Method for Mapping the Power and Cylinder of Multifocal Progressive Lenses", Ophthalmic & Visual Optics/Noninvasive Assessment of the Visual System Technical Digest, Vol. 3, PD1-1 through PD1-4, 1983.											
*Examiner	4	1. 1.0	6	+ 0.4		Date Consid	dered '	7 7 -	021				

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RI	Sciammarella et al., "D Experimental Mechani	Digital-filteri	ng Techniques A	pplied to the Inte	rpolation of Moir	é-fringes Da	ata",	
		<u>55, pp. 400</u>	, 110101111001					
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